# BOURNS®

- 5 A Continuous On-State Current
- 30 A Surge-Current
- Glass Passivated Wafer
- 400 V to 800 V Off-State Voltage
- Max I<sub>GT</sub> of 200 μA





Pin 2 is in electrical contact with the mounting base.

# absolute maximum ratings over operating case temperature (unless otherwise noted)

RATING			VALUE	UNIT
	TIC106D		400	v
Benetitive peak off state voltage (see Note 1)	TIC106M	M	600	
Repetitive peak off-state voltage (see Note 1)	TIC106S	VDRM	700	
	TIC106N		800	
	TIC106D		400	v
Repetitive peak reverse voltage	TIC106M	V	600	
	TIC106S	VRRM	700	
	TIC106N		800	
Continuous on-state current at (or below) 80°C case temperature (see Note 2)		I <sub>T(RMS)</sub>	5	А
Average on-state current (180° conduction angle) at (or below) 80°C case temperature			3.2	А
(see Note 3)			0.2	~
Surge on-state current at (or below) 25°C (see Note 4)			30	А
Peak positive gate current (pulse width < 300 µs)		I <sub>GM</sub>	0.2	А
Peak gate power dissipation (pulse width < 300 µs)		Р <sub>GM</sub>	1.3	W
Average gate power dissipation (see Note 5)		P <sub>G(AV)</sub>	0.3	W
Operating case temperature range			-40 to +110	°C
Storage temperature range		T <sub>stg</sub>	-40 to +125	°C
Lead temperature 1.6 mm from case for 10 seconds		Τ <sub>L</sub>	230	°C

NOTES: 1. These values apply when the gate-cathode resistance  $R_{GK}$  = 1 k\Omega.

2. These values apply for continuous dc operation with resistive load. Above 80°C derate linearly to zero at 110°C.

3. This value may be applied continuously under single phase 50 Hz half-sine-wave operation with resistive load. Above 80°C derate linearly to zero at 110°C.

4. This value applies for one 50 Hz half-sine-wave when the device is operating at (or below) the rated value of peak reverse voltage and on-state current. Surge may be repeated after the device has returned to original thermal equilibrium.

5. This value applies for a maximum averaging time of 20 ms.

# PRODUCT INFORMATION

MDC1ACA

# TIC106 SERIES SILICON CONTROLLED RECTIFIERS



### electrical characteristics at 25°C case temperature (unless otherwise noted)

	PARAMETER		TEST CONDITIO	NS	MIN	ТҮР	MAX	UNIT
I <sub>DRM</sub>	Repetitive peak off-state current	$V_{D}$ = rated $V_{DRM}$	$R_{GK} = 1 \ k\Omega$	T <sub>C</sub> = 110°C			400	μA
I <sub>RRM</sub>	Repetitive peak reverse current	$V_{R}$ = rated $V_{RRM}$	I <sub>G</sub> = 0	T <sub>C</sub> = 110°C			1	mA
I <sub>GT</sub>	Gate trigger current	V <sub>AA</sub> = 12 V	R <sub>L</sub> = 100 Ω	t <sub>p(g)</sub> ≥ 20 μs		5	200	μA
V <sub>GT</sub>	Gate trigger voltage	V <sub>AA</sub> = 12 V t <sub>p(g)</sub> ≥ 20 μs	R <sub>L</sub> = 100 Ω R <sub>GK</sub> = 1 kΩ	$T_{\rm C} = -40^{\circ}{\rm C}$			1.2	
		V <sub>AA</sub> = 12 V t <sub>p(g)</sub> ≥ 20 μs	R <sub>L</sub> = 100 Ω R <sub>GK</sub> = 1 kΩ		0.4	0.6	1	V
		V <sub>AA</sub> = 12 V t <sub>p(g)</sub> ≥ 20 μs	R <sub>L</sub> = 100 Ω R <sub>GK</sub> = 1 kΩ	$T_{C} = 110^{\circ}C$	0.2			
Ι <sub>Η</sub>	Holding current	$V_{AA} = 12 V$ Initiating I <sub>T</sub> = 10 mA	R <sub>GK</sub> = 1 kΩ	$T_{\rm C} = -40^{\circ}{\rm C}$			8	mA
		V <sub>AA</sub> = 12 V Initiating I <sub>T</sub> = 10 mA	$R_{GK} = 1 \ k\Omega$				5	ШA
$V_{T}$	Peak on-state voltage	I <sub>T</sub> = 5 A	(See Note 6)				1.7	V
dv/dt	Critical rate of rise of off-state voltage	$V_{\rm D}$ = rated $V_{\rm D}$	$R_{GK} = 1 \ k\Omega$	T <sub>C</sub> = 110°C		10		V/µs

NOTE 6: This parameter must be measured using pulse techniques,  $t_p = 300 \ \mu$ s, duty cycle  $\leq 2 \ \%$ . Voltage sensing-contacts, separate from the current carrying contacts, are located within 3.2 mm from the device body.

#### thermal characteristics

PARAMETER	MIN	ТҮР	MAX	UNIT
R <sub>0JC</sub> Junction to case thermal resistance			3.5	°C/W
R <sub>0JA</sub> Junction to free air thermal resistance			62.5	°C/W

# PRODUCT INFORMATION

# THERMAL INFORMATION



# PRODUCT INFORMATION

APRIL 1971 - REVISED SEPTEMBER 2002 Specifications are subject to change without notice.

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# **TYPICAL CHARACTERISTICS**



PRODUCT INFORMATION